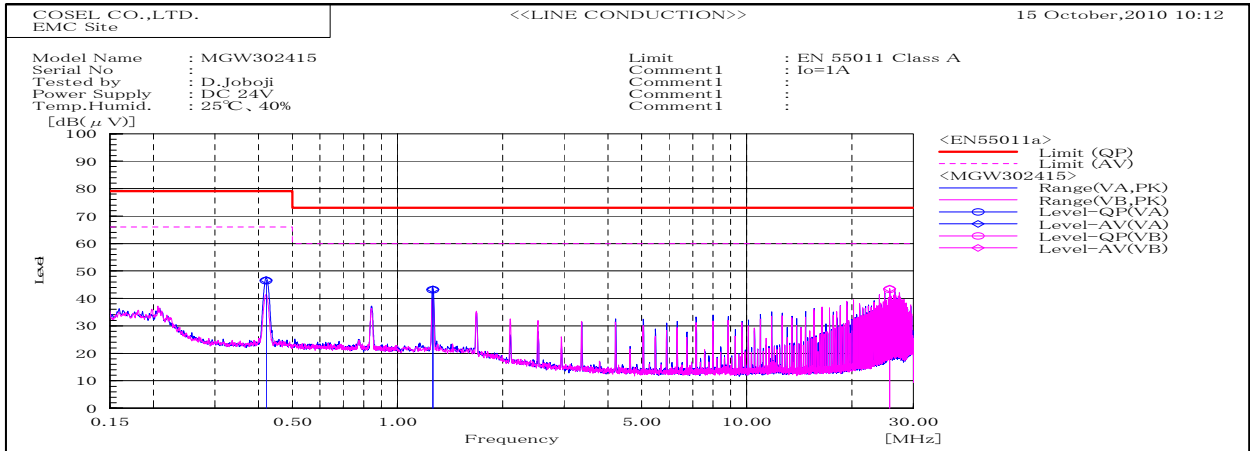
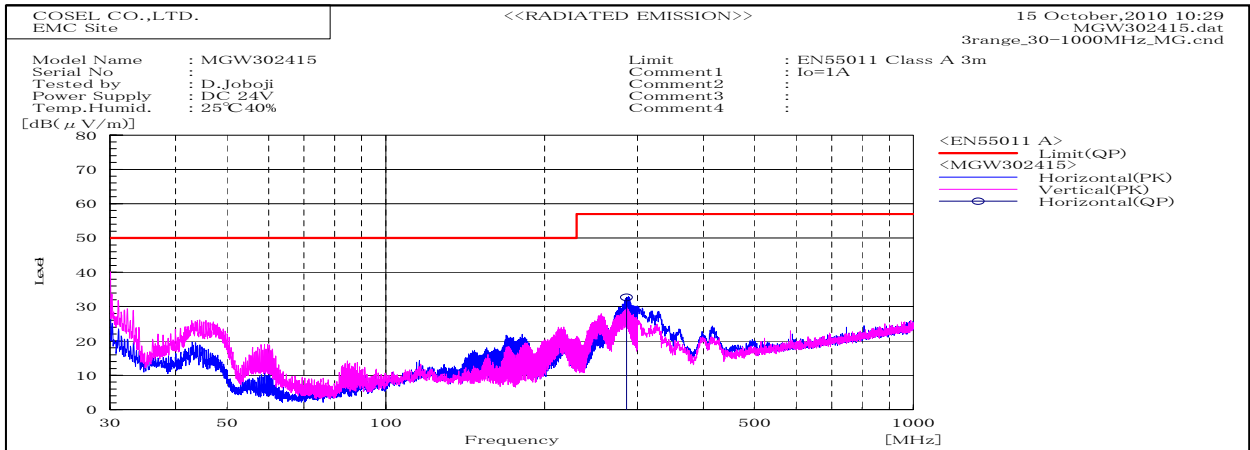


DATA SHEET			Date	19-Oct-10
Model	MGW302415		Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission		Humid.	40 %RH
			Tested by	D.Joboji



Frequency MHz	Harm	Line Phase	Reading dB(μV)		Factor dB	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/ Fail	Remark
			QP	AV		QP	AV	QP	AV	QP	AV		
0.42022		VA	36.4	36.6	10.1	46.5	46.7	79	66	32.5	19.3	Pass	
1.26109		VA	33.1	33.2	10.1	43.2	43.3	73	60	29.8	16.7	Pass	
25.6604		VB	32.2	32.5	11.1	43.3	43.6	73	60	29.7	16.4	Pass	



Frequency MHz	Polarization	Stability	Reading dB(μV)		Space Loss dB	Level dB(mW)	Limit dB(mW)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	AV		QP	QP	QP				
286.021	H	Stable	50.6		-17.9	32.7		57	24.3	Pass	114	156

DATA SHEET

Model	Circuit used for measurement
Test	EMI Line conduction & Radiated emission

1. Line conduction



2. Radiated emission

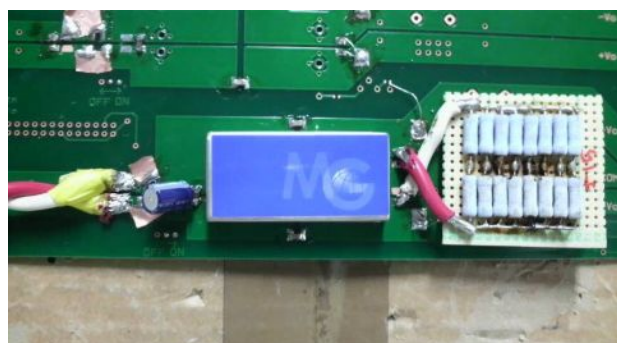


Conditions

Test : EMI
 Model Name : MGS3024□□/MGW3024□□

○Photographs of Test Set-Up

LINE CONDUCTION



RADIATED EMISSION



○Testing circuitry

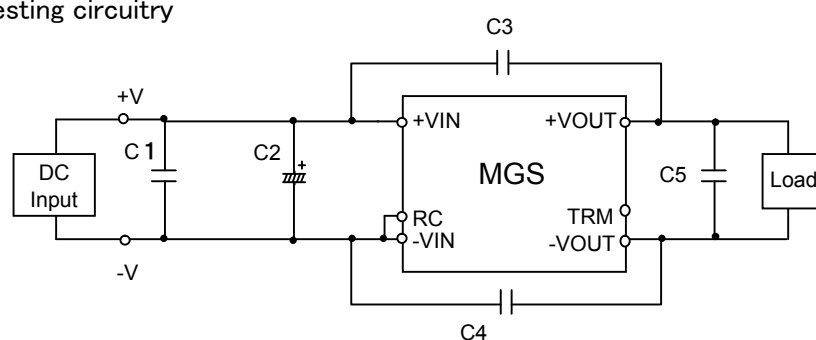


Fig.1 Testing circuitry 1

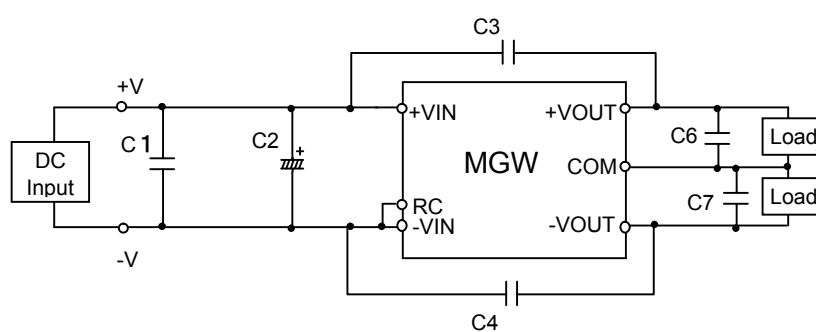


Fig.2 Testing circuitry 2

C1	: 50V	4.7 μ F	Ceramic Capacitor
C2	: 50V	100 μ F	Electrolytic Capacitor
C3,C4	: 2kV	1000pF	Ceramic Capacitor
C5,C6,C7	: 25V	22 μ F	Ceramic Capacitor